

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/676,819 WEDEL ET AL.	
		Examiner	Art Unit Qing Chen	2191 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,386,834 B2	06-2008	Van De Vanter et al.	717/110
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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